



# Test Report

No. :KA/2007/81382 Date: 2007/08/30 Page: 1 of 3

RALEC ELECTRONIC CORPORATION  
NO.1, CENTRAL 2nd STREET, NANTZE EXPORT PROCESSING ZONE, KAOHSIUNG  
,TAIWAN.



The following sample(s) was/were submitted and identified by/on behalf of the client as :

Sample Description	:	LEAD FREE CHIP RESISTOR PRODUCT
Style/Item No.	:	RTT25(2512T)RTT25J101
Color	:	SILVER/BLACK
Sample Receiving Date	:	2007/08/23
Testing Period	:	2007/08/23 TO 2007/8/30

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<b>Test Requested</b>	:	In accordance with the RoHS Directive 2002/95/EC, and its amendment directives.
<b>Test Method</b>	:	(1) With reference to US EPA Method 3050B for Lead Content. Analysis was performed by ICP-AES.
<b>Test Result(s)</b>	:	Please refer to next page(s).

  
**Katherine Ho / Supervisor**  
**Signed for and on behalf of**  
**SGS Taiwan Limited**

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